What is claimed is:

- 1. A substrate heater assembly for supporting a substrate of a predetermined standardized diameter during processing, comprising:
 - a body having an upper surface and a lower surface;
 - a heating element embedded within the body;
- a substrate support surface formed in the upper surface of the body and defining a portion of a substrate receiving pocket; and

an annular wall oriented perpendicular to the upper surface and having a length of at least one half a thickness of the substrate, the wall bounding an outer perimeter of the substrate receiving pocket and having a diameter less than about 0.5 mm greater than the predetermined substrate diameter.

- 2. The assembly of claim 1 further comprising:
- a ring disposed in substrate receiving pocket, wherein the wall is at least a portion of an inner diameter of the ring.
- 3. The assembly of claim 2, wherein the ring further comprises: a bevel flaring outward from the wall of the ring.
- 4. The assembly of claim 3, wherein the bevel is a continuous lip extending beyond the upper surface and circumscribing the wall.
- 5. The assembly of claim 3, wherein the bevel further comprises:
- a plurality of discreet crowns extending beyond the upper surface and circumscribing the wall.
- 6. The assembly of claim 3, wherein the ring further comprises: an annular flange radially outward of the wall.
- 7. The assembly of claim 6, wherein the flange further comprises: a plurality of slots formed therein.

PATENT 8295/DSM/BCVD/JW

- 8. The assembly of claim 2, wherein the annular ring is formed from a ceramic material.
- 9. The assembly of claim 2, wherein the annular ring further comprises:
 - a height of about 0.7 to 7 mm; and
- a ratio of the height to a width of the annular ring between about 0.05:1 and 0.5:1.
- 10. The assembly of claim 3, wherein the bevel tapers outward and upward at an angle of about 10 to 40 degrees.
- 11. The assembly of claim 4, wherein the lip further comprises:
 - a height of about 0.5 to 5 mm;
 - a ratio of the height to a width of the lip between about 0.3:1 and 3:1; and
- an inner portion tapered outward and upward at an angle of about 10 to 40 degrees.
- 12. The assembly of claim 5, wherein at least one of the plurality of discreet crowns further comprises:
 - a height of about 0.5 to 5mm;
 - a ratio of the height to a width of the crown between about 0.3:1 and 3:1; and
- an inner portion tapered outward and upward at an angle of about 10 to 40 degrees.
- 13. The assembly of claim 1 wherein the heater member is formed from a ceramic material.
- 14. The assembly of claim 1, wherein the wall is couples the upper surface to the substrate support surface of the body.
- 15. The assembly of claim 14, wherein the body further comprises: a bevel flaring outward from the wall of the body.

- 16. The assembly of claim 15, wherein the bevel is a continuous lip extending beyond the upper surface and circumscribing the wall.
- 17. The assembly of claim 15, wherein the bevel further comprises:
- a plurality of discreet crowns extending beyond the upper surface and circumscribing the wall.
- 18. The assembly of claim 15, wherein the bevel tapers outward and upward at an angle of about 10 to 40 degrees.
- 19. The assembly of claim 16, wherein the lip further comprises:
 - a height of about 0.5 to 5 mm;
 - a ratio of the height to a width of the lip between about 0.3:1 and 3:1; and
- an inner portion tapered outward and upward at an angle of about 10 to 40 degrees.
- 20. The assembly of claim 17, wherein at least one of the plurality of discreet crowns further comprises:
 - a height of about 0.5 to 5mm;
 - a ratio of the height to a width of the crown between about 0.3:1 and 3:1; and an inner portion tapered outward and upward at an angle of about 10 to 40
- degrees.
- 21. An apparatus for processing a substrate of a predetermined standardized diameter, comprising:
- a chemical vapor deposition chamber having a ceramic substrate heater assembly disposed therein, wherein the heater assembly comprises:
 - a body having an upper surface and a lower surface;
 - a heating element embedded within the body;
 - a substrate support surface formed in the upper surface of the body and defining a portion of a substrate receiving pocket; and
 - an annular wall oriented perpendicular to the upper surface and having a length of at least one half a thickness of the substrate, the wall bounding an outer perimeter of the substrate receiving pocket and having a diameter less

PATENT 8295/DSM/BCVD/JW

than about 0.5 mm greater than the predetermined substrate diameter.

- 22. An apparatus for processing a substrate of a predetermined standardized diameter, comprising:
- a chemical vapor deposition chamber having a ceramic substrate heater assembly disposed therein, wherein the heater assembly comprises:
 - a body having an upper surface and a lower surface;
 - a heating element embedded within the body;
 - a substrate support surface formed in the upper surface of the body and defining a portion of a substrate receiving pocket;
 - an annular wall coupled between the substrate support surface and the upper surface, the wall having a length of at least one half a thickness of the substrate and a diameter less than about 0.5 mm greater than the predetermined substrate diameter; and
 - a plurality of crowns protruding from the upper surface, each of the crowns having an inner portion joined with the bevel.
- 23. The assembly of claim 22, wherein at least one of the plurality of discreet crowns further comprises:
 - a height of about 0.5 to 5mm;
- a ratio of the height to a width of the crown between about 0.3:1 and 3:1; and an orientation of the inner portion tapered outward and upward at an angle of about 10 to 40 degrees.